

Notice of References Cited	Application/Control No. 10/670,699	Applicant(s)/Patent Under Reexamination MATABAYAS, JAMES CHRISTO	
	Examiner Mark Eashoo, Ph.D.	Art Unit 1732	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,265,466	07-2001	Glatkowski et al.	523/137
*	B	US-2004/0016912	01-2004	Bandyopadhyay et al.	252/500
*	C	US-6,387,996	05-2002	Lan et al.	524/445
*	D	US-2004/0094750	05-2004	Widagdo et al.	252/500
*	E	US-6,451,422	09-2002	Nguyen, My N.	428/323
*	F	US-2004/0177451	09-2004	Poulin et al.	008/115.51
*	G	US-2003/0151030	08-2003	Gurin, Michael H.	252/502
*	H	US-2004/0097635	05-2004	Fan et al.	524/496
*	I	US-6,764,628	07-2004	Lobovsky et al.	264/172.15
*	J	US-2002/0185770	12-2002	McKague, Elbert Lee	264/108
*	K	US-6,486,253	11-2002	Gilmer et al.	524/445
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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